## Search Notes



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Hsieh, Ping Y

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## **SEARCHED**

Class	Subclass	Date	Examiner
455	76, 85, 86, 87, 118, 147, 148, 165.1, 183.1, 323, 324	7/18/08	PH

SEARCH NOTES				
Search Notes	Date	Examiner		
Text search in EAST (see search history)	7/18/08	PH		
PLUS search	1/28/08	PH		
Consulted with Yuwen Pan	7/18/08	PH		

INTERFERENCE SEARCH						
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